

# Silicon Carbide (SiC) MOSFET - EliteSiC, 960 mohm, 1700 V, M1, TO-247-3L NTHL1000N170M1

### **Features**

- Typ.  $R_{DS(on)} = 960 \text{ m}\Omega$
- Ultra Low Gate Charge (typ. Q<sub>G(tot)</sub> = 14 nC)
- Low Effective Output Capacitance (typ. Coss = 11 pF)
- 100% Avalanche Tested
- RoHS Compliant

### **Typical Applications**

- Solar Inverters
- Electric Vehicle Charging Stations
- Electric Storing Systems
- SMPS (Switch Mode Power Supplies)
- UPS (Uninterruptible Power Supplies)

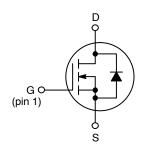
### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	1700	V
Gate-to-Source Voltage			$V_{GS}$	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage		$V_{GSop}$	-5/+20	<b>V</b>	
Continuous Drain Current (Note 1)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	4.2	Α
Power Dissipation (Note 1)			P <sub>D</sub>	48	W
Continuous Drain Current (Note 1)	Steady State	T <sub>C</sub> = 100°C	I <sub>D</sub>	3	Α
Power Dissipation (Note 1)			P <sub>D</sub>	24	W
Pulsed Drain Current (Note 2)	T <sub>C</sub> = 25°C		I <sub>DM</sub>	14	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			Is	9.5	Α
Single Pulse Drain-to-Source Avalanche Energy (Note 3)			E <sub>AS</sub>	24	mJ
Maximum Lead Temperature for Soldering (1/25" from case for 10 s)			T <sub>L</sub>	270	°C

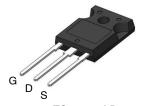
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Repetitive rating, limited by max junction temperature.
- 3. E<sub>AS</sub> of 24 mJ is based on starting  $T_J = 25$  °C; L = 1 mH, I<sub>AS</sub> = 6.9 A,  $V_{DD} = 120$  V,  $V_{GS} = 20$  V.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX	
1700 V	960 mΩ @ 20 V	4.2 A	

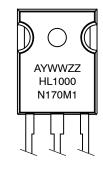


**N-CHANNEL MOSFET** 



TO-247-3LD CASE 340CX

### MARKING DIAGRAM



A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

HL1000N170M1 = Specific Device Code

### **ORDERING INFORMATION**

Device	Package	Shipping
NTHL1000N170M1	TO-247-3L	30 Units / Tube

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 1)	$R_{ heta JC}$	3.1	°C/W

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Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	1		1	1		1
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$		1700			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25°C (Note 4)			0.5		V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 1700 \text{ V}$	T <sub>J</sub> = 25°C			100	μΑ
		V <sub>DS</sub> = 1700 V	T <sub>J</sub> = 175°C			1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +25/-15 V$ ,	$V_{DS} = 0 V$			±1	μΑ
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	640 μΑ	1.8	3.2	4.3	V
Recommended Gate Voltage	$V_{GOP}$			-5		+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 20 \text{ V}, I_D = 2 \text{ A}$	A, T <sub>J</sub> = 25°C		960	1430	mΩ
		V <sub>GS</sub> = 20 V, I <sub>D</sub> = 2 A, (Note 4)			1800		
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2	A (Note 4)		0.6		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE (Note	4)				•	•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 1000 V			150		pF
Output Capacitance	C <sub>OSS</sub>				11		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				0.6		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$ $I_{D} = 2 \text{ A}$			14		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.5		
Gate-to-Source Charge	Q <sub>GS</sub>	1			2.6		
Gate-to-Drain Charge	$Q_{GD}$	]			7.5		
Gate-Resistance	$R_{G}$	f = 1 MHz			5.7		Ω
SWITCHING CHARACTERISTICS (Notes 4	l, 5)						
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = -5/20			5.6		ns
Rise Time	t <sub>r</sub>	$V_{DS} = 800$ $I_{D} = 2 A$	V,		30		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 2 A$ , $R_G = 25 \Omega$ inductive load $L = 300 \mu H$			11		
Fall Time	t <sub>f</sub>				84		
Turn-On Switching Loss	E <sub>ON</sub>	1			120		μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	-			11		·
Total Switching Loss	E <sub>tot</sub>				131		
DRAIN-SOURCE DIODE CHARACTERIST							
Continuous Drain-Source Diode Forward Current (Note 1)	I <sub>SD</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub>	= 25°C			9.5	Α
Pulsed Drain-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>					48	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 2 /	A, T <sub>J</sub> = 25°C		4.2		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = -5/20 V, I <sub>SD</sub> = 2 A, dI <sub>S</sub> /dt = 1000 A/μs (Note 4)			5.9		ns
Reverse Recovery Charge	Q <sub>RR</sub>				11		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Defined by design, not subject to production test.

5. E<sub>ON</sub>/E<sub>OFF</sub> result is with body diode.

### **TYPICAL CHARACTERISTICS**

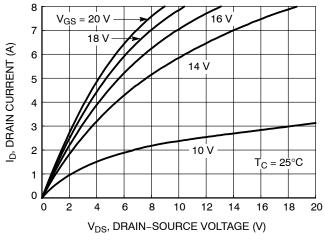


Figure 1. On-Region Characteristics

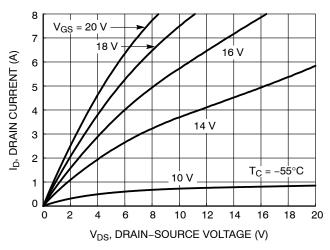


Figure 2. On-Region Characteristics

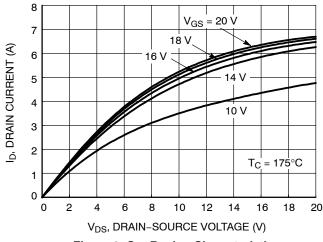


Figure 3. On-Region Characteristics

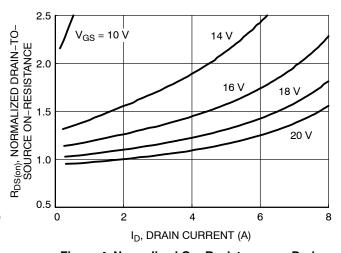


Figure 4. Normalized On-Resistance vs. Drain Current and Gate Voltage

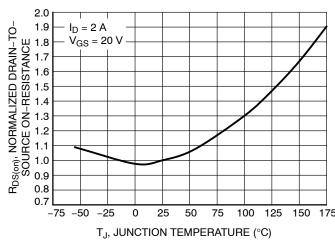


Figure 5. Normalized On–Resistance Variation with Temperature

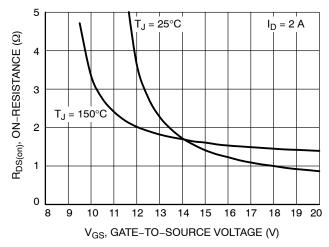


Figure 6. On-Resistance vs. Gate-to-Source Voltage

### **TYPICAL CHARACTERISTICS**

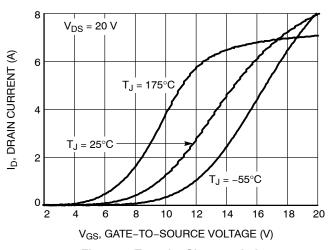


Figure 7. Transfer Characteristics

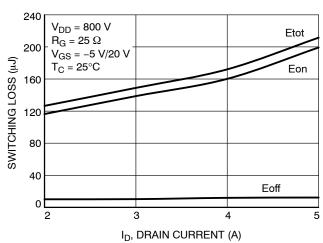


Figure 8. Switching Loss vs. Drain Current

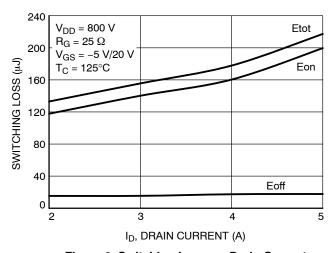


Figure 9. Switching Loss vs. Drain Current

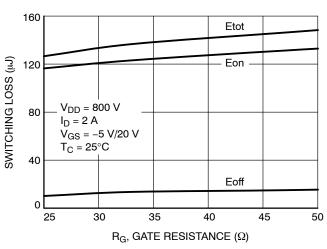


Figure 10. Switching Loss vs. Gate Resistance

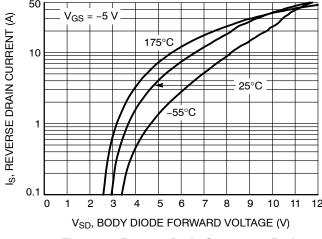


Figure 11. Reverse Drain Current vs. Body Diode Forward Voltage

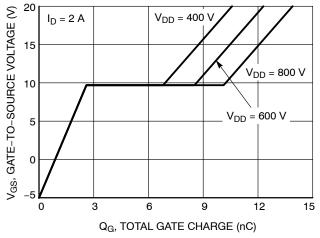


Figure 12. Gate-to-Source Voltage vs. Total Charge

### **TYPICAL CHARACTERISTICS**

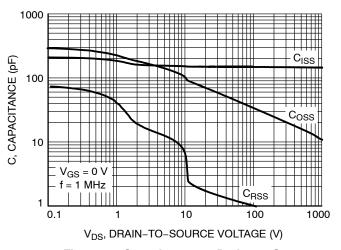


Figure 13. Capacitance vs. Drain-to-Source Voltage

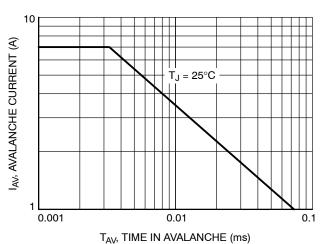


Figure 14. Unclamped Inductive Switching Capability

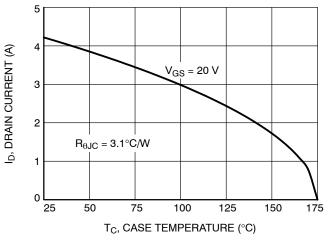


Figure 15. Maximum Continuous Drain Current vs. Case Temperature

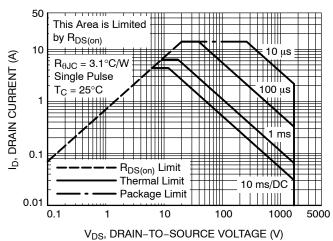


Figure 16. Maximum Rated Forward Biased Safe Operating Area

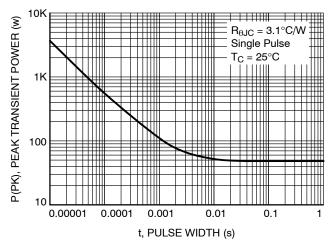


Figure 17. Single Pulse Maximum Power Dissipation

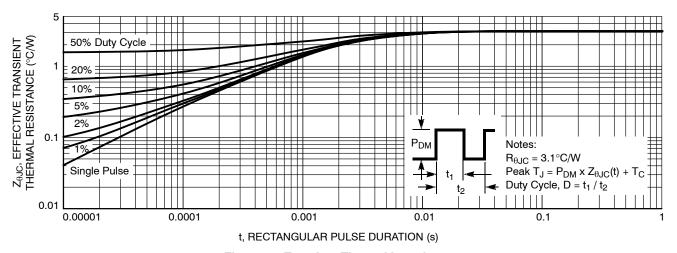
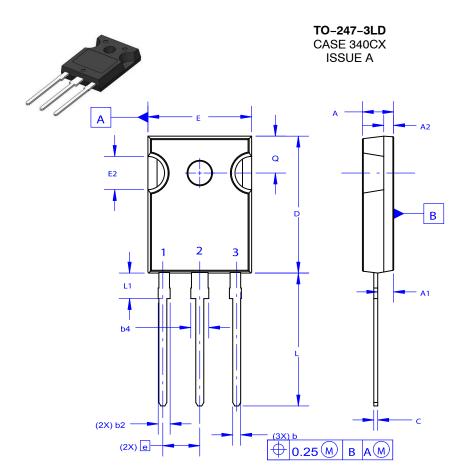


Figure 18. Transient Thermal Impedance

### **ESD RATINGS**

ESD Test	Classification	Standard
ESD-HBM	0B (125 V to <250 V)	ANSI/ESDA/JEDEC JS-001
ESD-CDM	C3 (>1000 V)	ANSI/ESDA/JEDEC JS-002

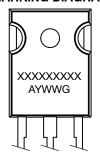
**DATE 06 JUL 2020** 



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

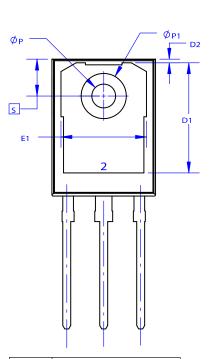
# GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
<b>A</b> 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
D	20.32	20.57	20.82		
E	15.37	15.62	15.87		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	19.75	20.00	20.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E1	12.81	~	~		
ØP1	6.60	6.80	7.00		

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C3M0045065K E3M0120090J C3M0065090J-TR C3M0120100J C3M0075120J DMWS120H100SM4 DMWSH120H28SM4
DMWSH120H90SM4 DMWSH120H90SM4Q DMWSH120H28SM4Q DMWSH120H90SCT7Q DMWSH120H28SM3
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G3R40MT12J